


<b>Search Notes</b> 	<b>Application/Control No.</b> 10623767	<b>Applicant(s)/Patent Under Reexamination</b> YOSHINO ET AL.
	<b>Examiner</b> Cai, Wayne	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
705	14	4/3/07	WHC
709	206	4/3/07	WHC
455	566	4/3/07	WHC

SEARCH NOTES		
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INTERFERENCE SEARCH			
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